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 Assistant Commissioner for Patents,
 Washington, D.C., 20231, on 12/6/01

Deborah W. Wenocur

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of:

Applicant:	K. Sabota, D. Schonauer, J. Groschopf,) G. Marxsen, and S. Avanzino,)	Grp Art Unit: 1765
Assignee:	Advanced Micro Devices, Inc.)	Exam: L. Umez Eronini
Serial Number:	09/749,191))
Filed:	December 26, 2000))
For:	PREVENTION OF PRECIPITATION) DEFECTS ON COPPER INTER-) CONNECTS DURING CMP BY USE) OF SOLUTIONS CONTAINING) ORGANIC COMPOUNDS WITH) SILICA ADSORPTION AND COPPER) CORROSION INHIBITING) PROPERTIES))

Assistant Commissioner for Patents
 Washington, D.C. 20231

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RESPONSE TO RESTRICTION REQUIREMENT

Dear Sir,

This is in response to the Office Action mailed on November 27, 2001.

The Examiner has required restriction to either: slurry composition claims 1-55, or method claims 56 – 73. Applicant respectfully traverses this restriction requirement. The slurry composition claims specifically recite the slurry's use in polishing Ta layers in integrated circuit metallization systems. It is therefore

E0520CIP

submitted that the product can only be used according to the claimed process, and
that the process is specifically directed to the claimed product.

In the event that the traverse is not successful, Applicant provisionally
elects method claims 56 - 73.

Respectfully submitted,

Deborah W. Wenocur

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.12/6/01

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RE: 09/749,191

Response to Restriction Requirement

5 pages

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